

ANNEXE I/ANNEX I

LISTE DES PARTICIPANTS/
LIST OF PARTICIPANTS

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(dans l'ordre alphabétique des noms français des États/
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II. ÉTAT OBSERVATEUR/OBSERVER STATE

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III. ORGANISATIONS INTERGOUVERNEMENTALES/
INTERGOVERNMENTAL ORGANIZATIONS

OFFICE EUROPÉEN DES BREVETS (OEB)/EUROPEAN PATENT OFFICE (EPO)

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ORGANISATION EURASIENNE DES BREVETS (OEAB)/EURASIAN PATENT
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IV. BUREAU/OFFICERS

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Vice-présidents/Vice-Chairs:	Klaus D. HÖFKEN (Allemagne/Germany) Antonio Carlos SOUZA DE ABRANTES (Brésil/Brazil)
Secrétaire/Secretary:	Antonios FARASSOPOULOS (OMPI/WIPO)

V. BUREAU INTERNATIONAL DE L'ORGANISATION MONDIALE DE LA PROPRIÉTÉ INTELLECTUELLE (OMPI)/INTERNATIONAL BUREAU OF THE WORLD INTELLECTUAL PROPERTY ORGANIZATION (WIPO)

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[L'annexe II suit/
Annex II follows]